


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/563,607	LIARD ET AL.	
	Examiner	Art Unit	
	Truc T. T. Nguyen	2833	

SEARCHED			
Class	Subclass	Date	Examiner
439	567	5/25/2007	TN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
439/567	5/25/2007	TN